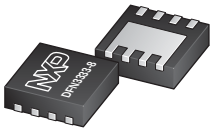


PSMN014-60LS

N-channel DFN3333-8 60 V 14 mΩ standard level MOSFET

Rev. 3 — 8 December 2011 Product data sheet

1. Product profile

1.1 General description

Standard level N-channel MOSFET in DFN3333-8 package qualified to 150 °C. This product is designed and qualified for use in a wide range of industrial, communications and power supply equipment.

1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Small footprint for compact designs
- Suitable for standard level gate drive sources

1.3 Applications

- DC-to-DC converters
- Lithium-ion battery protection
- Load switching

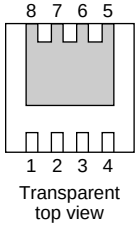
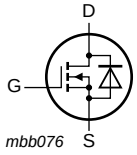
1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25$ °C; $T_j \leq 150$ °C	-	-	60	V
I_D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see Figure 1	-	-	40	A
P_{tot}	total power dissipation	T_{mb} = 25 °C; see Figure 2	-	-	65	W
T_j	junction temperature		-55	-	150	°C
Static characteristics						
R_{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 10 A; T_j = 100 °C; see Figure 11	-	-	22	mΩ
		V_{GS} = 10 V; I_D = 10 A; T_j = 25 °C; see Figure 12	-	11	14	mΩ
Dynamic characteristics						
Q_{GD}	gate-drain charge	V_{GS} = 10 V; I_D = 15 A; V_{DS} = 30 V; see Figure 13; see Figure 14	-	4.5	-	nC
$Q_{G(tot)}$	total gate charge		-	19.6	-	nC
Avalanche ruggedness						
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 40 A; $V_{sup} \leq 60$ V; unclamped; R_{GS} = 50 Ω	-	-	42	mJ

2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		
2	S	source		
3	S	source		
4	G	gate		
5,6,7,8	D	drain		
mb	D	mounting base; connected to drain		

SOT873-1 (DFN3333-8)

3. Ordering information

Table 3. Ordering information

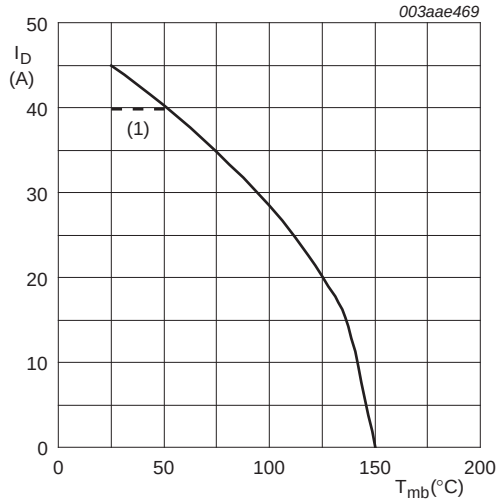
Type number	Package		
	Name	Description	Version
PSMN014-60LS	DFN3333-8	plastic thermal enhanced very thin small outline package; no leads; 8 terminals	SOT873-1

4. Limiting values

Table 4. Limiting values

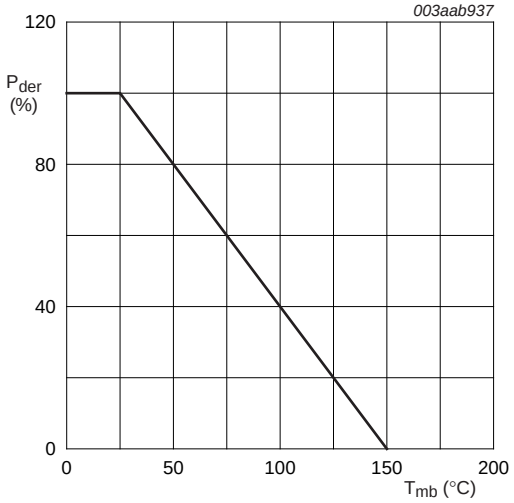
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25$ °C; $T_j \leq 150$ °C	-	60	V
V_{DGR}	drain-gate voltage	$T_j \leq 150$ °C; $T_j \geq 25$ °C; R_{GS} = 20 kΩ	-	60	V
V_{GS}	gate-source voltage		-20	20	V
I_D	drain current	V_{GS} = 10 V; T_{mb} = 100 °C; see Figure 1	-	28	A
		V_{GS} = 10 V; T_{mb} = 25 °C; see Figure 1	-	40	A
I_{DM}	peak drain current	pulsed; $t_p \leq 10$ µs; T_{mb} = 25 °C; see Figure 3	-	180	A
P_{tot}	total power dissipation	T_{mb} = 25 °C; see Figure 2	-	65	W
T_{stg}	storage temperature		-55	150	°C
T_j	junction temperature		-55	150	°C
$T_{sld(M)}$	peak soldering temperature		-	260	°C
Source-drain diode					
I_S	source current	T_{mb} = 25 °C	-	40	A
I_{SM}	peak source current	pulsed; $t_p \leq 10$ µs; T_{mb} = 25 °C	-	180	A
Avalanche ruggedness					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 40 A; $V_{sup} \leq 60$ V; unclamped; R_{GS} = 50 Ω	-	42	mJ



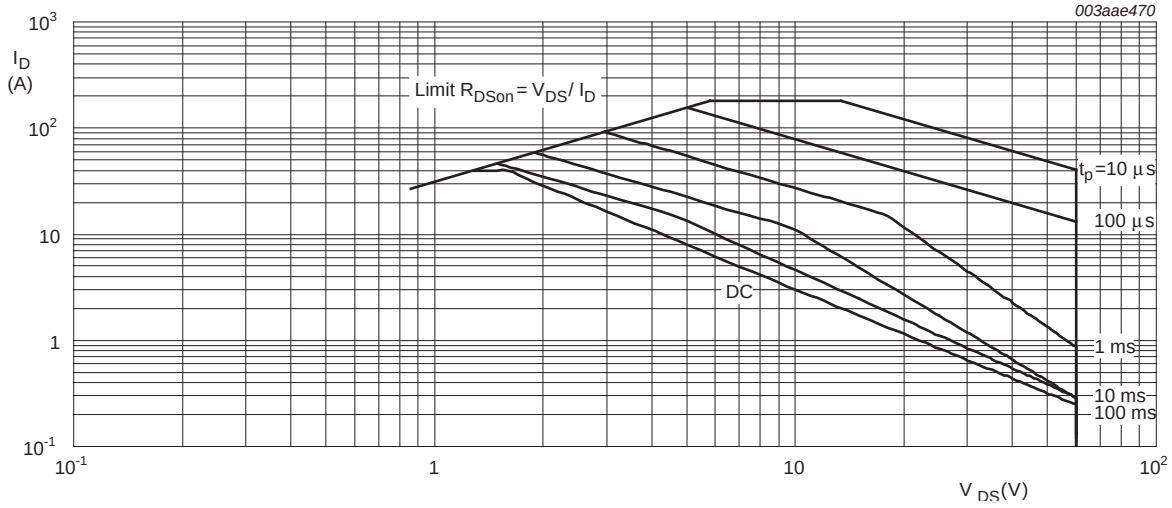
$V_{GS} \geq 10\,V$; (1) Capped at 40 A due to package.

Fig 1. Continuous drain current as a function of mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25°C)}} \times 100\,\%$$

Fig 2. Normalized total power dissipation as a function of solder point temperature



$T_{mb} = 25\,°C$; I_{DM} is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
$R_{th(j\text{-}mb)}$	thermal resistance from junction to mounting base	see Figure 4		-	1	1.3	K/W
$R_{th(j\text{-}a)}$	thermal resistance from junction to ambient		[1]	-	53	60	K/W

[1] $R_{th(j\text{-}a)}$ is guaranteed by design and assumes that the device is mounted on a 40mm x 40mm x 70 µm copper pad at 20°C ambient temperature. In practice $R_{th(j\text{-}a)}$ will be determined by the customer's PCB characteristics

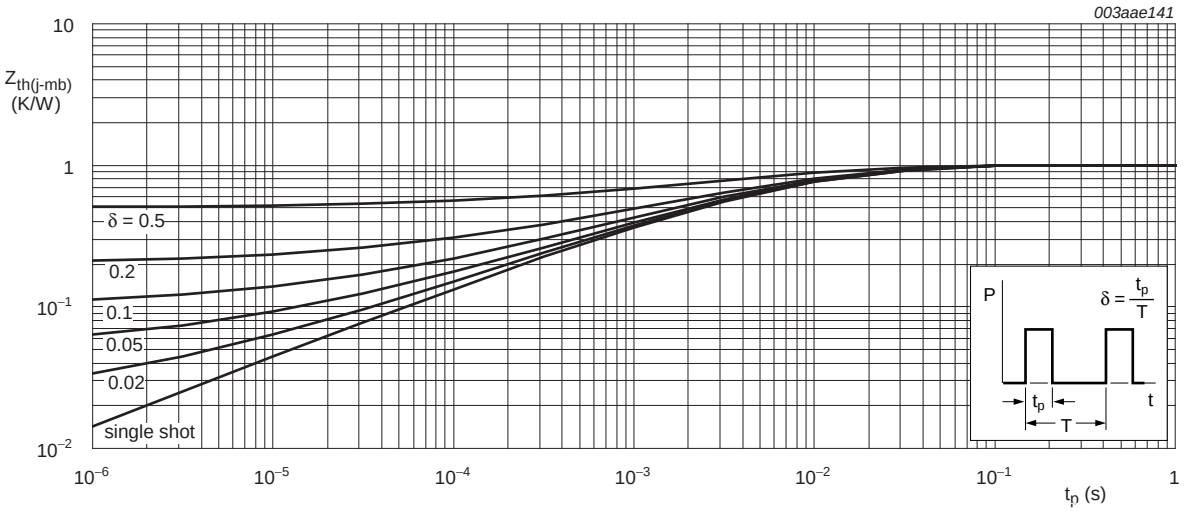


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration; typical values

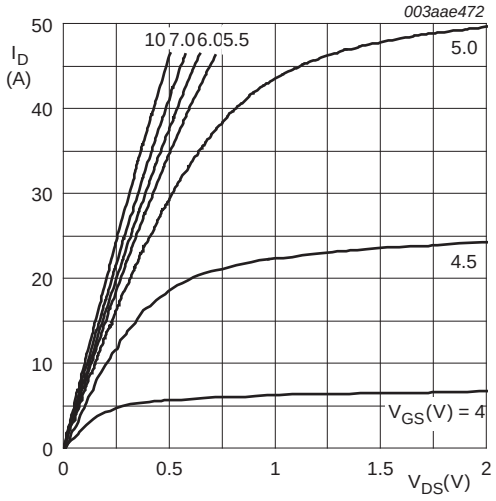
6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 0.25 mA; V_{GS} = 0 V; T_j = -55 °C	54	-	-	V
		I_D = 0.25 mA; V_{GS} = 0 V; T_j = 25 °C	60	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS}; T_j = 150 °C; see Figure 9	1	-	-	V
		I_D = 1 mA; V_{DS} = V_{GS}; T_j = 25 °C; see Figure 9; see Figure 10	2.3	3	4	V
		I_D = 1 mA; V_{DS} = V_{GS}; T_j = -55 °C; see Figure 9	-	-	4.7	V
I_{DSS}	drain leakage current	V_{DS} = 60 V; V_{GS} = 0 V; T_j = 25 °C	-	0.1	2	µA
		V_{DS} = 60 V; V_{GS} = 0 V; T_j = 125 °C	-	-	50	µA
I_{GSS}	gate leakage current	V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
		V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
R_{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 10 A; T_j = 100 °C; see Figure 11	-	-	22	mΩ
		V_{GS} = 10 V; I_D = 10 A; T_j = 150 °C; see Figure 11	-	23.1	29.4	mΩ
		V_{GS} = 10 V; I_D = 10 A; T_j = 25 °C; see Figure 12	-	11	14	mΩ
R_G	internal gate resistance (AC)	f = 1 MHz	-	1.1	-	Ω
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	I_D = 15 A; V_{DS} = 30 V; V_{GS} = 10 V; see Figure 13; see Figure 14	-	19.6	-	nC
		I_D = 0 A; V_{DS} = 0 V; V_{GS} = 10 V	-	16.8	-	nC
Q_{GS}	gate-source charge	I_D = 15 A; V_{DS} = 30 V; V_{GS} = 10 V; see Figure 13; see Figure 14	-	5.7	-	nC
$Q_{GS(th)}$	pre-threshold gate-source charge		-	3.6	-	nC
$Q_{GS(th-pl)}$	post-threshold gate-source charge		-	2.1	-	nC
Q_{GD}	gate-drain charge		-	4.5	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	V_{DS} = 30 V; see Figure 13; see Figure 14	-	4.65	-	V
C_{iss}	input capacitance	V_{DS} = 30 V; V_{GS} = 0 V; f = 1 MHz; T_j = 25 °C; see Figure 15	-	1264	-	pF
C_{oss}	output capacitance		-	171	-	pF
C_{rss}	reverse transfer capacitance		-	91	-	pF
$t_{d(on)}$	turn-on delay time	V_{DS} = 30 V; R_L = 2 Ω; V_{GS} = 10 V; $R_{G(ext)}$ = 4.7 Ω; T_j = 25 °C	-	11	-	ns
t_r	rise time		-	5	-	ns
$t_{d(off)}$	turn-off delay time		-	21	-	ns
t_f	fall time		-	5	-	ns

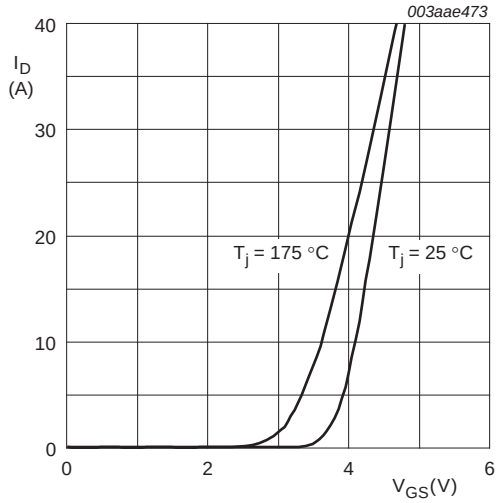
Table 6. Characteristics *...continued*

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Source-drain diode						
V_{SD}	source-drain voltage	I_S = 15 A; V_{GS} = 0 V; T_j = 25 °C; see Figure 16	-	0.85	1.2	V
t_{rr}	reverse recovery time	I_S = 15 A; dI_S/dt = 100 A/µs; V_{GS} = 0 V; V_{DS} = 30 V	-	33	-	ns
Q_r	recovered charge		-	36	-	nC



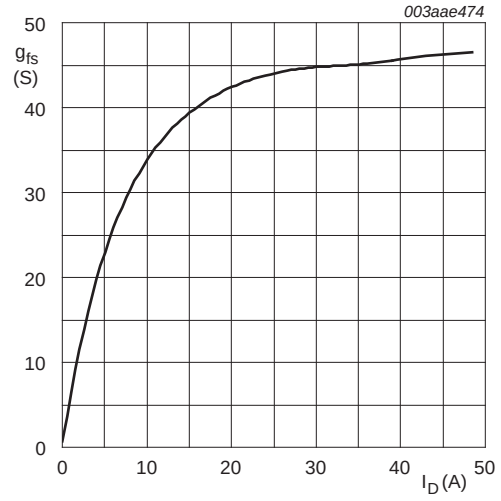
$T_j = 25\,°C$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



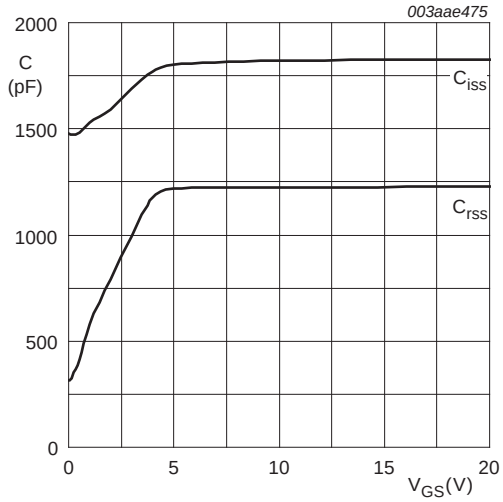
$V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values



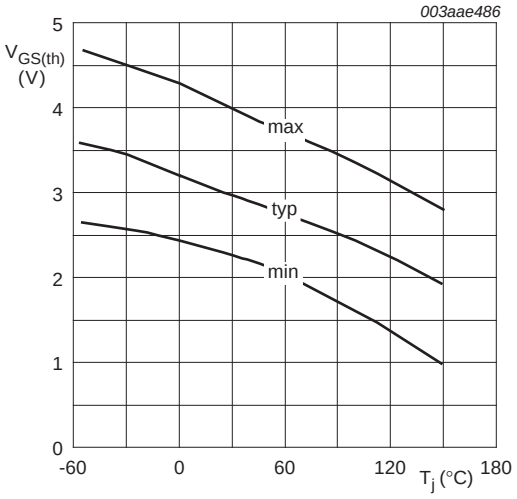
$T_j = 25\,°C; V_{DS} = 10\,V$

Fig 7. Forward transconductance as a function of drain current; typical values



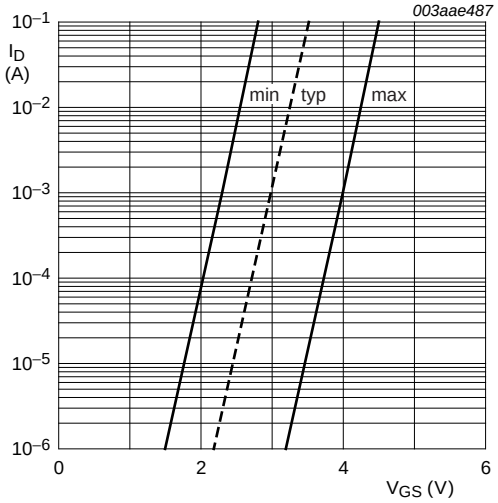
$V_{DS} = 0\,V; f = 1\,MHz$

Fig 8. Input and reverse transfer capacitances as a function of gate-source voltage; typical values



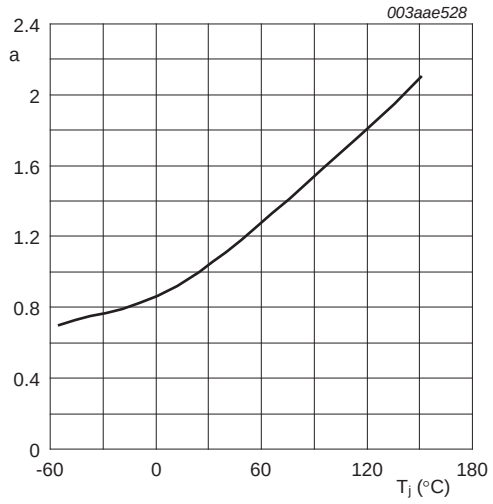
$I_D = 1mA; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



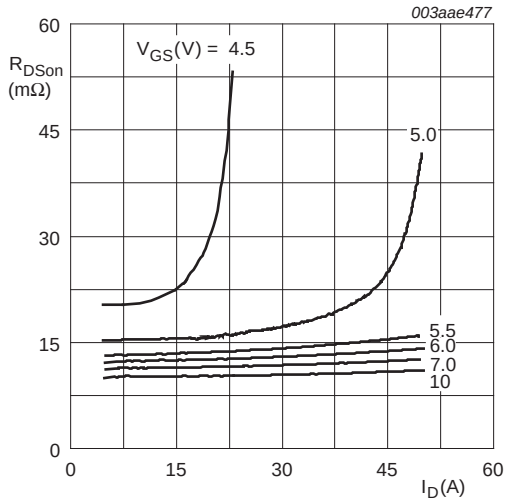
$T_j = 25\,°C; V_{DS} = 5V$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



$$a = \frac{R_{DSon}}{R_{DSon}(25\,°C)}$$

Fig 11. Normalized drain-source on-state resistance factor as a function of junction temperature



$T_j = 25\,°C$

Fig 12. Drain-source on-state resistance as a function of drain current; typical values

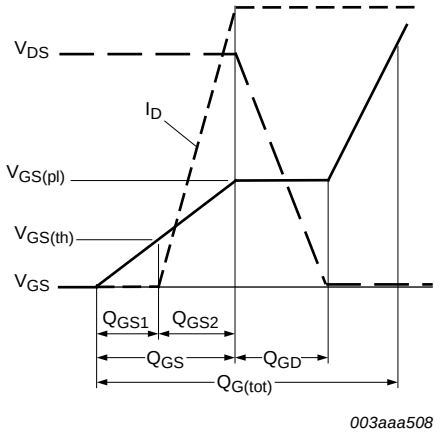
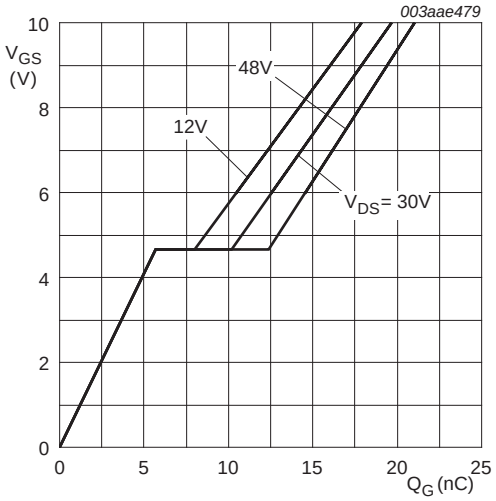
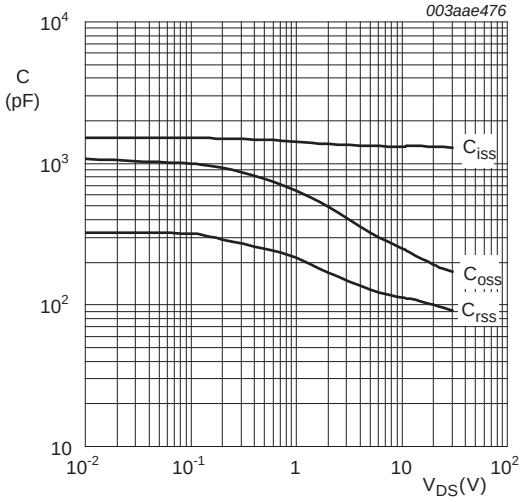


Fig 13. Gate charge waveform definitions



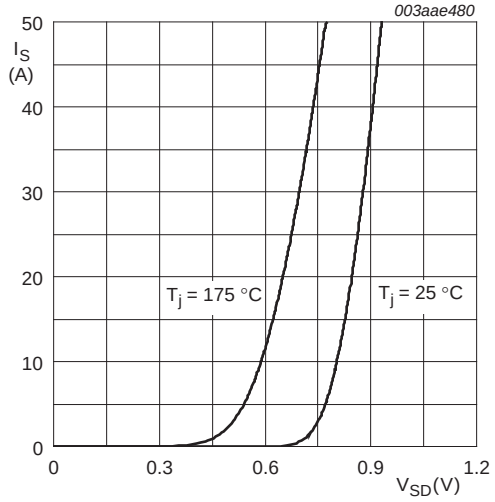
$T_j = 25\,°C; I_D = 15A$

Fig 14. Gate-source voltage as a function of gate charge; typical values



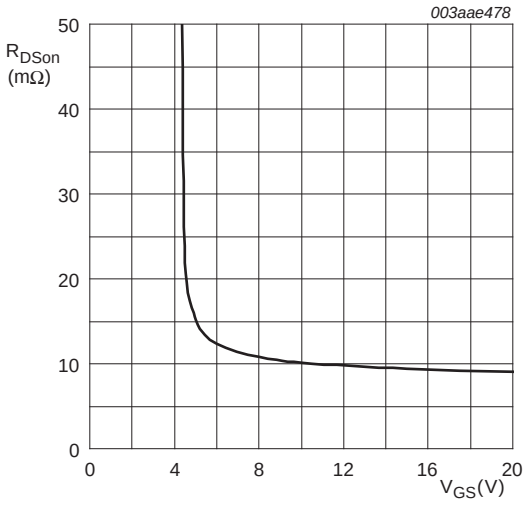
$V_{GS} = 0V; f = 1MHz$

Fig 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



$V_{GS} = 0V$

Fig 16. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

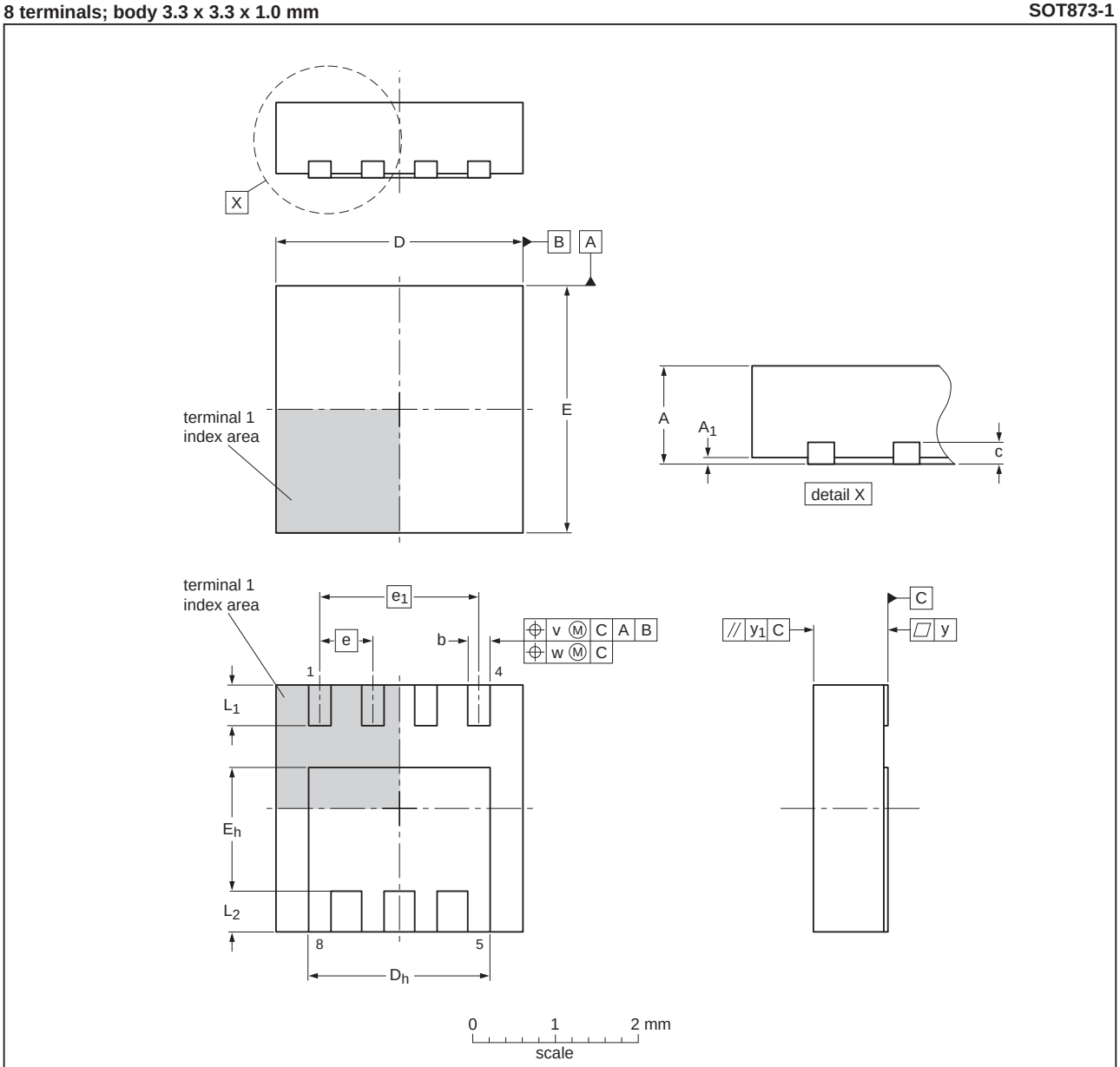


$T_j = 25\,°C; I_D = 15\,A$

Fig 17. Drain-source on-state resistance as a function of gate-source voltage; typical values

7. Package outline

DFN3333-8: plastic thermal enhanced very thin small outline package; no leads; 8 terminals; body 3.3 x 3.3 x 1.0 mm **SOT873-1**



DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A_1	b	c	D	D_h	E	E_h	e	e_1	L_1	L_2	v	w	y	y_1
mm	1	0.05 0.00	0.45 0.25	0.2	3.4 3.2	2.4 2.2	3.4 3.2	1.80 1.58	0.65	1.95	0.55 0.45	0.52 0.35	0.1	0.05	0.1	0.1

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT873-1	- - -	- - -	- - -			~~10-04-19~~ 11-12-01

Fig 18. Package outline SOT873-1 (DFN3333-8)

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN014-60LS v.3	20111208	Product data sheet	-	PSMN014-60LS v.2
Modifications:	• Various changes to content.			
PSMN014-60LS v.2	20100818	Product data sheet	-	PSMN014-60LS v.1

9. Legal information

9.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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10. Contact information

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: salesaddresses@nxp.com

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